



AP/21-13  
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Docket No.: 826.1697

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

# 7

In re the Application of:

Makoto MURAISHI, et al.

Serial No. 09/804,268

Group Art Unit: 2173

Confirmation No. 9108

Filed: March 13, 2001

Examiner: T. T. Chuong

RECEIVED

JUN 22 2004

Technology Center 2100

For: TEST SUPPORT APPARATUS AND TEST SUPPORT METHOD FOR GUI SYSTEM PROGRAM

**REQUEST FOR INTERVIEW**

**Via Facsimile 703-746-8690**

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

Sir:

The undersigned requests a personal interview with the Examiner on or before June 23, 2004, the due date of the response in this application. The undersigned contacted the Examiner to request that this interview be scheduled approximately one (1) week ago. The Examiner is requested to telephone the undersigned as soon as possible to schedule the interview. The interview can discuss the possible amendments to the claims discussed below.

1. A test support apparatus for supporting a test of a screen program using a graphic user interface, comprising:
  - a test support class generation unit obtaining screen definition information defining about a test target screen program, and generating a test support class which is a subclass inheriting a class of the test target screen program responsive according to the screen definition information, and a class for testing the test target screen program; and
  - a test execution unit conducting a test of the test target screen program defined by the screen definition information using the generated test support class to thereby test the screen program using the graphical user interface.

The present invention, as recited above, is directed to a system for testing a screen program that uses a graphical user interface. In contrast, Wimble is directed to a general high level debugging system that breaks a complex problem down into simpler sub-problems. Wimble does not discuss the particular details of the claims of the present invention. For

example, the present invention obtains screen definition information that defines and is used to generate a test target program used to test the target screen program. Wimble does not address such a level of detail.

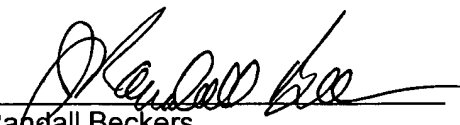
The Examiner is requested to contact the undersigned as soon as possible.

If any further fees, other than and except for the issue fee, are necessary with respect to this paper, the U.S.P.T.O. is requested to obtain the same from deposit account number 19-3935:

Respectfully submitted,

STAAS & HALSEY LLP

Date: 6/10/4

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